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Patent and Trademark Office: U.S. DEPARTMENT OF COMMERCE

Substitute for form 1449A/PTO				Application Number	10/079,270
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary) PD				Filing Date	2/20/02
				First Named Inventor	Steven Teig
				Group Art Unit	2825
				Examiner Name	PAUL DINH
Sheet	1	of	3	Attorney Docket Number	SPLX.P0127

U.S. PATENTS RELATED TO THE PRESENT APPLICATIONS

Examiner* Initials	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication MM-DD-YYYY	Relation to Present Application
PD	1.	6,516,455	B1	Teig, et al.	02-04-03	CIP of parent application

U.S. PATENT DOCUMENTS

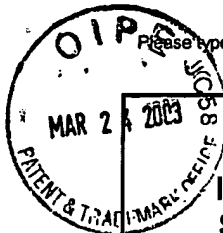
Examiner* Initials	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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PD	22.	6,068,662		Scepanovic et al.	05-30-00	

Examiner Signature	Paul Dinh	Date Considered	3/14/06
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¹ Unique citation designation number. ² See attached Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

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Examiner Initials	Cite No. ¹	Foreign Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
PD	41.	JP	64-15947	Ouchi	01-19-89		

NON PATENT LITERATURE DOCUMENTS							
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					T ⁶

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Sheet 3 of 3

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